TOSHIBA Insulated Gate Bipolar Transistor Silicon N Channel IGBT

GT60N321

High Power Switching Applications Fourth Generation IGBT

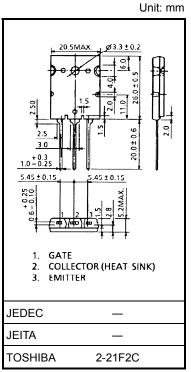
- FRD included between emitter and collector
- Enhancement mode type
- High speed IGBT : $t_f = 0.25 \mu s$ (typ.) (IC = 60 A)

FRD : $t_{rr} = 0.8 \mu s$ (typ.) (di/dt = -20 A/ μs)

• Low saturation voltage: VCE (sat) = 2.3 V (typ.) (IC = 60 A)

Maximum Ratings (Ta = 25°C)

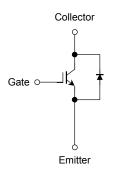
Characteristics		symbol	Rating	Unit	
Collector-Emitter Voltage		V _{CES}	1000	V	
Gate-Emitter Voltage		V _{GES}	±25	V	
Collector Current	DC	I _C	60	А	
	1 ms	I _{CP}	120		
Emitter-Collector Forward Current	DC	I _{ECF}	15	А	
	1 ms	I _{ECFP}	120		
Collector Power Dissipation (Tc = 25°C)		P _C	170	W	
Junction Temperature		Tj	150	°C	
Storage Temperature		T _{stg}	−55~150	°C	
Screw Torque		_	0.8	N∙m	

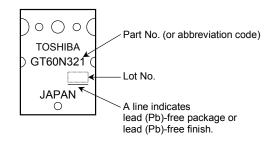


Weight: 9.75 g (typ.)

Equivalent Circuit

Marking



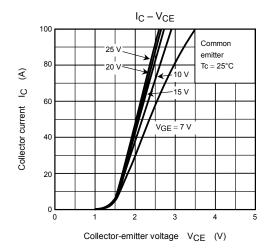


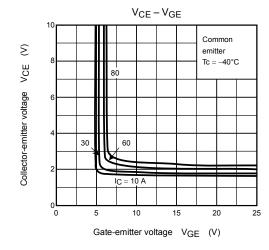
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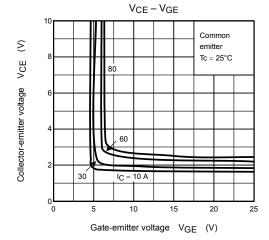
Electrical Characteristics (Ta = 25°C)

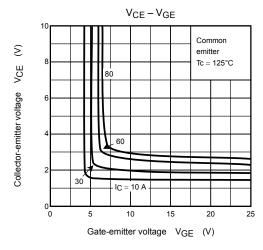
Chara	acteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate Leakage Current		I _{GES}	$V_{GE} = \pm 25 \text{ V}, V_{CE} = 0$	_	_	±500	nA
Collector Cut-off Current		I _{CES}	V _{CE} = 1000 V, V _{GE} = 0	_	_	1.0	mA
Gate-Emitter Cut-off Voltage		V _{GE} (OFF)	$I_C = 60 \text{ mA}, V_{CE} = 5 \text{ V}$	3.0	_	6.0	V
Collector-Emitter Saturation Voltage		V _{CE (sat)} (1)	I _C = 10 A, V _{GE} = 15 V	_	1.6	2.3	V
Collector-Emitter Saturation Voltage		V _{CE (sat)} (2)	$I_C = 60 \text{ A}, V_{GE} = 15 \text{ V}$	_	2.3	2.8	V
Input Capacitance		C _{ies}	$V_{CE} = 10 \text{ V}, V_{GE} = 0, f = 1 \text{ MHz}$	_	4000	_	pF
Switching Time Fa	Rise Time	t _r	51 Ω C C C C C C C C C C C C C C C C C C	_	0.23	_	
	Turn-on Time	t _{on}		_	0.33	_	
	Fall Time	t _f			0.25	0.40	μS
	Turn-off Time	t _{off}			0.70	_	
Emitter-Collector Forward Voltage		V _{ECF}	I _{EC} = 15 A, V _{GE} = 0	_	1.5	2.0	V
Reverse Recovery Time t _{rr}		t _{rr}	$I_F = 15 \text{ A}, V_{GE} = 0, di/dt = -20 \text{ A/}\mu\text{s}$	_	0.8	2.5	μS
Thermal Resistance		R _{th(j-c)}	_	_	_	0.74	°C/W
Thermal Resistance		R _{th(j-c)}	_	_	_	4.0	°C/W

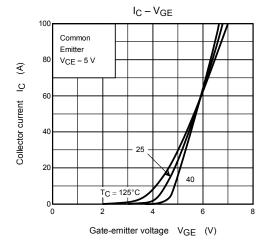
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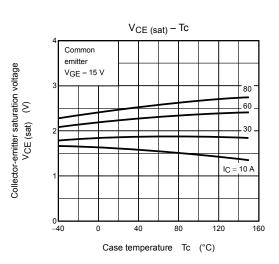


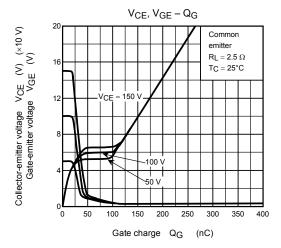


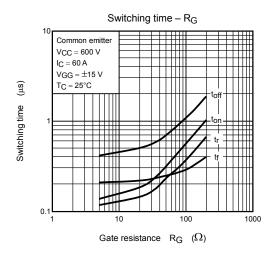


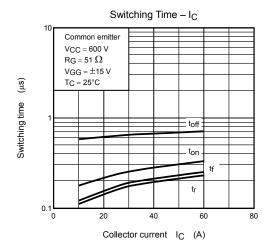


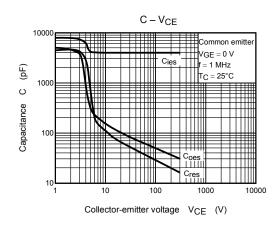


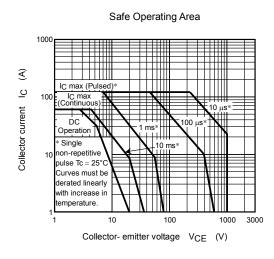


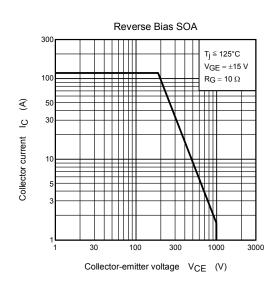


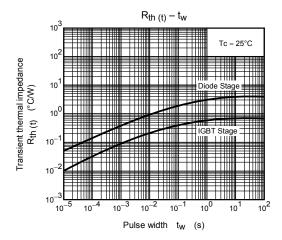


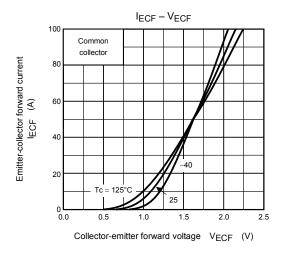


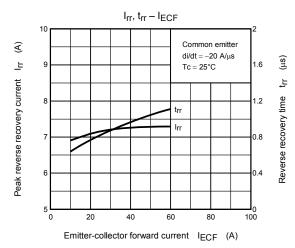


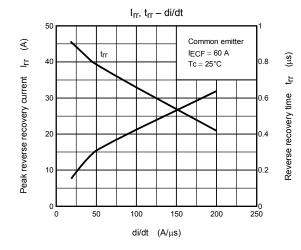












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